

RoHS Compliant Product
A suffix of "-C" specifies halogen & lead-free

DESCRIPTION

The SSG24N04S-C is the Shielded Gate Technology N-Ch MOSFETs with extreme high cell density, which provide excellent $R_{DS(ON)}$ and gate charge for most of the synchronous buck converter applications.

The SSG24N04S-C meet the RoHS and Green Product requirement with full function reliability approved.

FEATURES

- Shielded Gate Trench Technology
- Super Low Gate Charge
- Green Device Available

MARKING

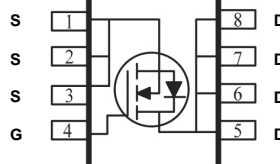


PACKAGE INFORMATION

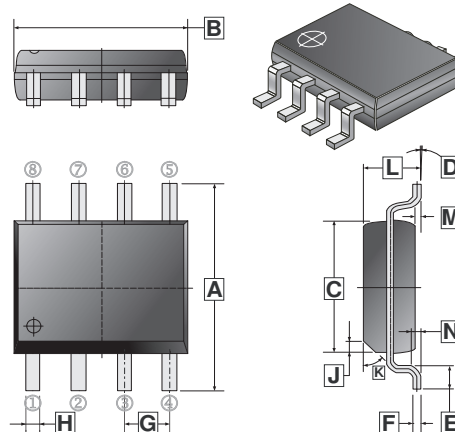
Package	MPQ	Leader Size
SOP-8	2.5K	13 inch

ORDER INFORMATION

Part Number	Type
SSG24N04S-C	Lead (Pb)-free and Halogen-free

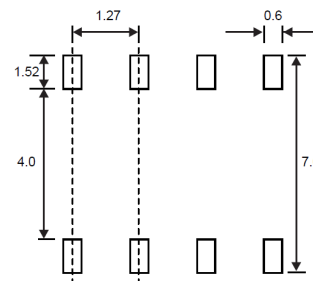


SOP-8



REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	5.79	6.20	H	0.33	0.51
B	4.70	5.11	J	0.375 REF.	
C	3.80	4.00	K	45° REF.	
D	0°	8°	L	1.3	1.752
E	0.40	1.27	M	0	0.25
F	0.10	0.25	N	0.25 REF.	
G	1.27 TYP.				

Mounting Pad Layout



*Dimensions in millimeters

ABSOLUTE MAXIMUM RATINGS ($T_A=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Ratings	Unit	
Drain-Source Voltage	V_{DS}	40	V	
Gate-Source Voltage	V_{GS}	± 20	V	
Continuous Drain Current ¹ @ $V_{GS}=10\text{V}$	$T_A=25^\circ\text{C}$	24	A	
	$T_A=70^\circ\text{C}$	19		
Pulsed Drain Current ²	I_{DM}	70	A	
Power Dissipation ³	$T_A=25^\circ\text{C}$	P_D	3.1	W
Operating Junction & Storage Temperature Range	T_J, T_{STG}	-55~150	$^\circ\text{C}$	
Thermal Resistance Ratings				
Thermal Resistance Junction-Ambient ¹	Steady State	$R_{\theta JA}$	75	$^\circ\text{C/W}$
	$t \leq 10\text{s}$		40	

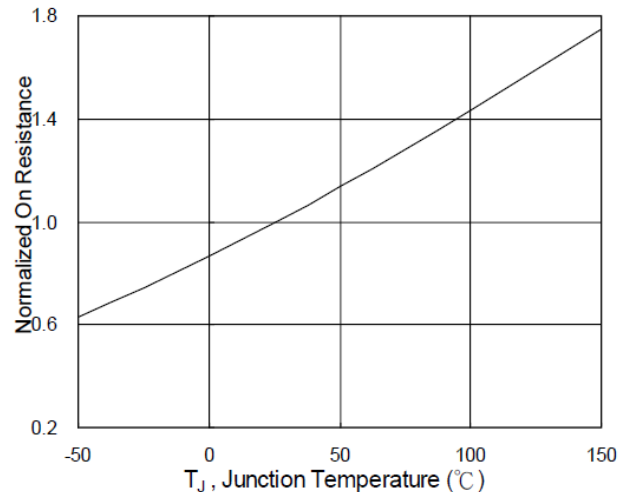
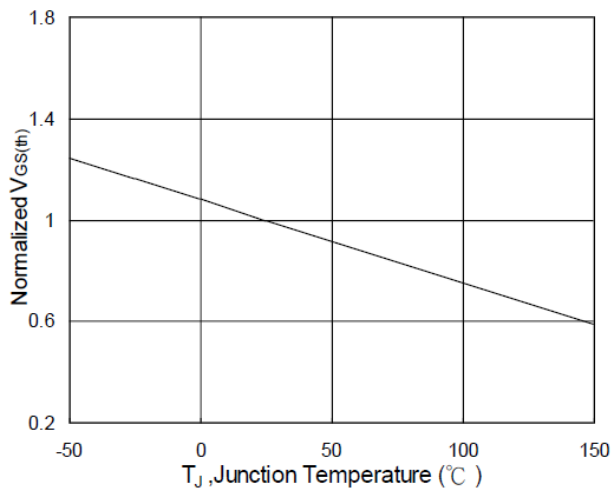
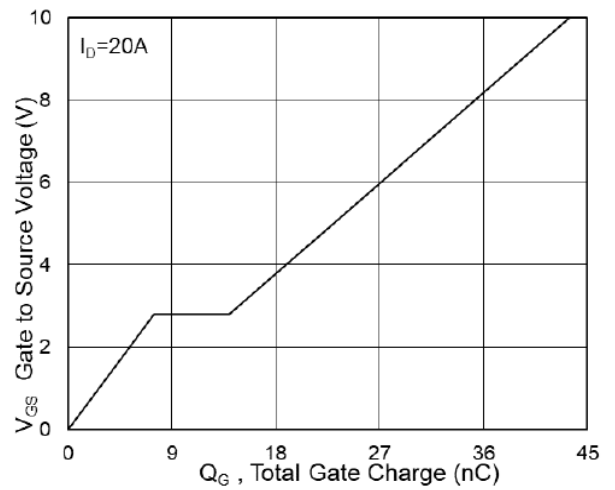
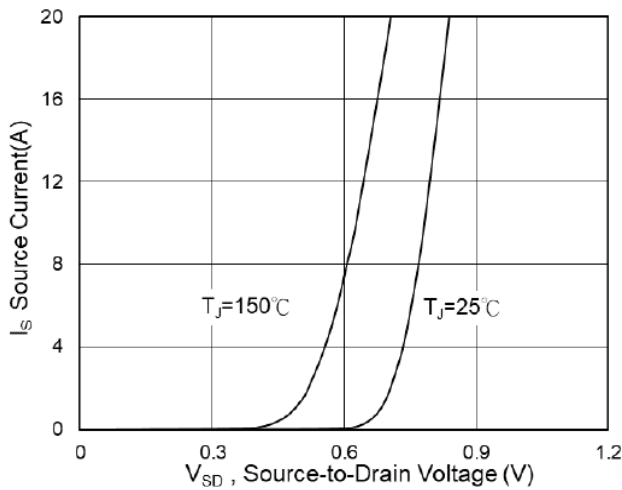
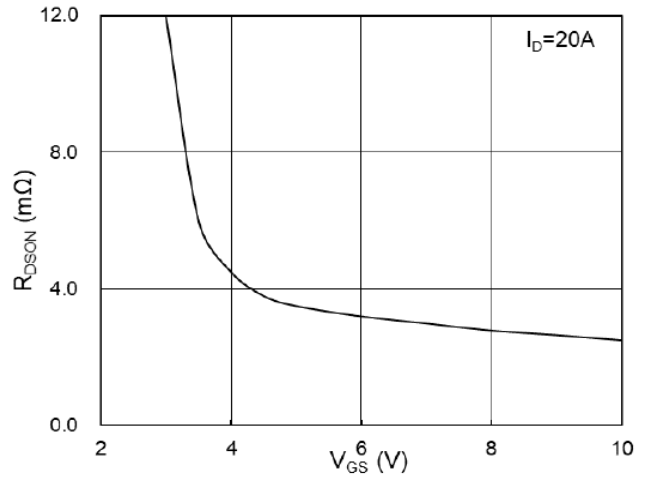
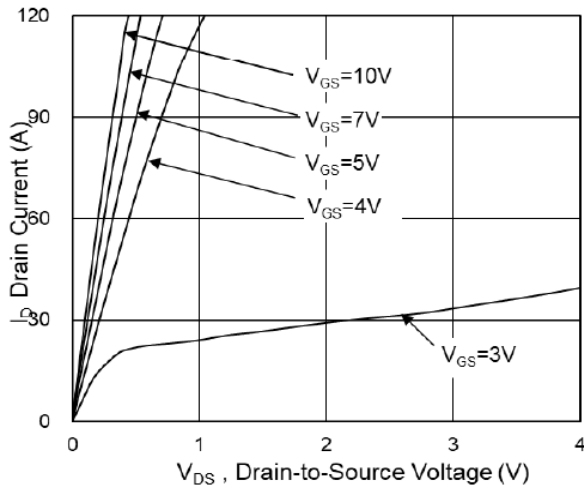
ELECTRICAL CHARACTERISTICS ($T_J=25^\circ C$ unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test condition
Drain-Source Breakdown Voltage	BV_{DSS}	40	-	-	V	$V_{GS}=0V, I_D=250\mu A$
Gate-Threshold Voltage	$V_{GS(th)}$	1	-	2.5	V	$V_{DS}=V_{GS}, I_D=250\mu A$
Forward Transfer Conductance	g_{fs}	-	75	-	S	$V_{DS}=5V, I_D=20A$
Gate-Source Leakage Current	I_{GSS}	-	-	± 100	nA	$V_{GS}=\pm 20V$
Drain-Source Leakage Current	$T_J=25^\circ C$	-	-	1	μA	$V_{DS}=32V, V_{GS}=0V$
	$T_J=55^\circ C$	-	-	5		
Static Drain-Source On-Resistance ²	$R_{DS(ON)}$	-	2.5	3.6	m Ω	$V_{GS}=10V, I_D=20A$
		-	3.8	5.3		$V_{GS}=4.5V, I_D=15A$
Gate Resistance	R_g	-	1.5	-	Ω	$V_{DS}=0V, V_{GS}=0V, f=1MHz$
Total Gate Charge	Q_g	-	22.7	-	nC	$I_D=20A$ $V_{DS}=20V$ $V_{GS}=4.5V$
Gate-Source Charge	Q_{gs}	-	7.5	-		
Gate-Drain ("Miller") Charge	Q_{gd}	-	5.5	-		
Turn-On Delay Time	$T_{d(on)}$	-	10	-	nS	$V_{DD}=20V$ $I_D=20A$ $V_{GS}=10V$ $R_G=3\Omega$
Rise Time	T_r	-	5	-		
Turn-Off Delay Time	$T_{d(off)}$	-	33	-		
Fall Time	T_f	-	6.5	-		
Input Capacitance	C_{iss}	-	2648	-	pF	$V_{GS}=0V$ $V_{DS}=20V$ $f=1MHz$
Output Capacitance	C_{oss}	-	899	-		
Reverse Transfer Capacitance	C_{rss}	-	71	-		
Source-Drain Diode						
Diode Forward Voltage ²	V_{SD}	-	-	1	V	$I_S=1A, V_{GS}=0V, T_J=25^\circ C$
Continuous Source Current ^{1 4}	I_S	-	-	24	A	$V_G=V_D=0V, \text{Force Current}$

Notes:

1. The data tested by surface mounted on a 1 inch² FR-4 board with 2oz copper.
2. The data tested by pulsed, pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$.
3. The power dissipation is limited by 150 $^\circ C$ junction temperature.
4. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.

CHARACTERISTICS CURVE



CHARACTERISTICS CURVE

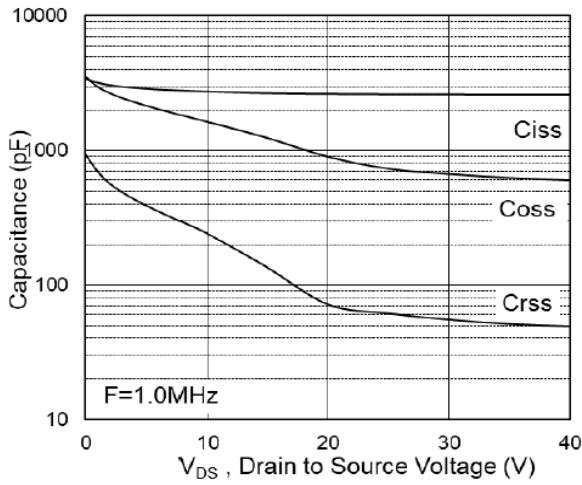


Fig.7 Capacitance

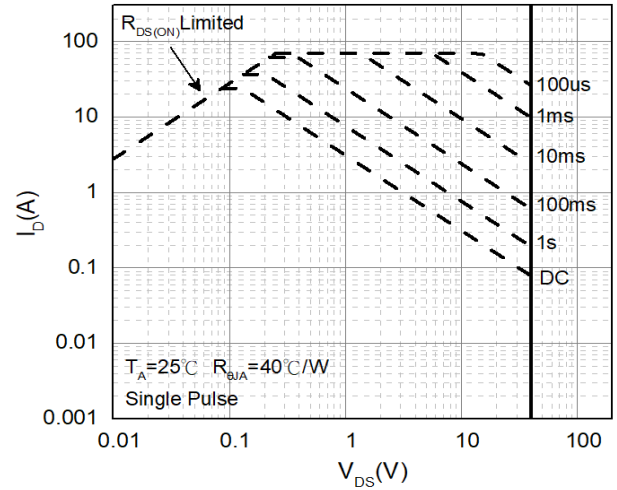


Fig.8 Safe Operating Area

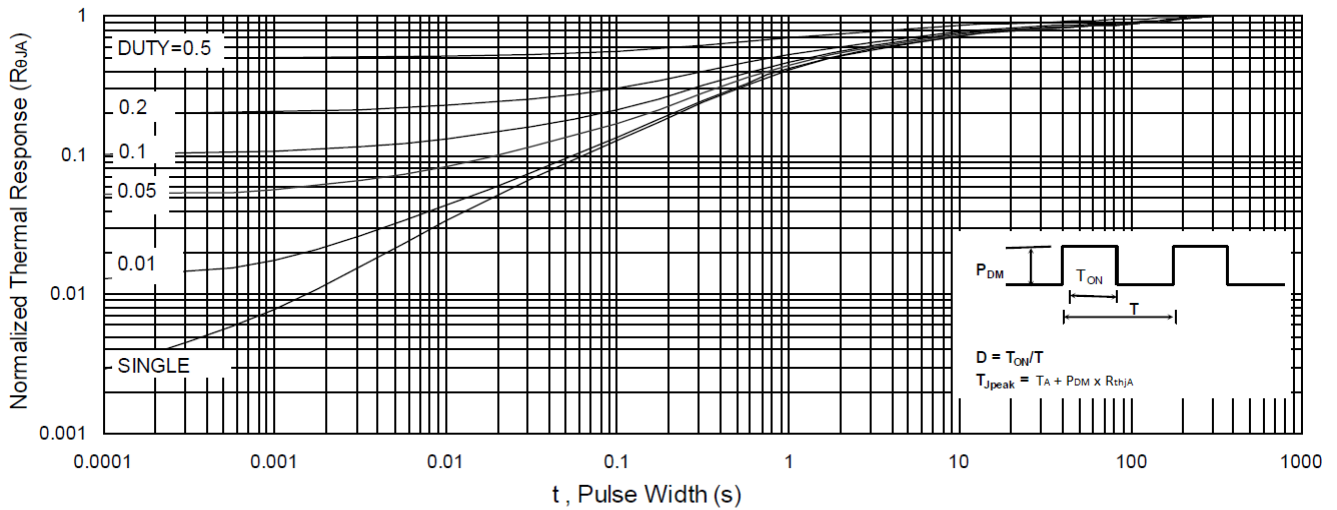


Fig.9 Normalized Maximum Transient Thermal Impedance

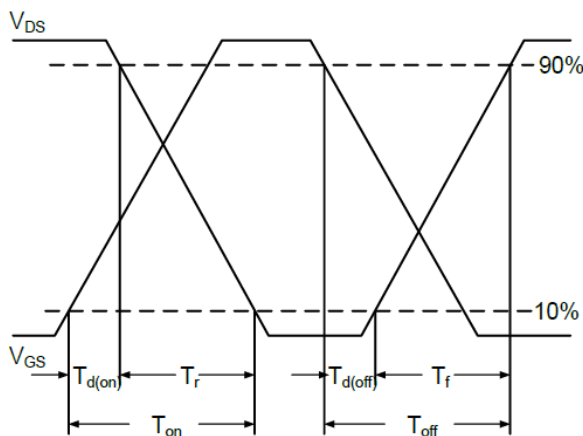


Fig.10 Switching Time Waveform

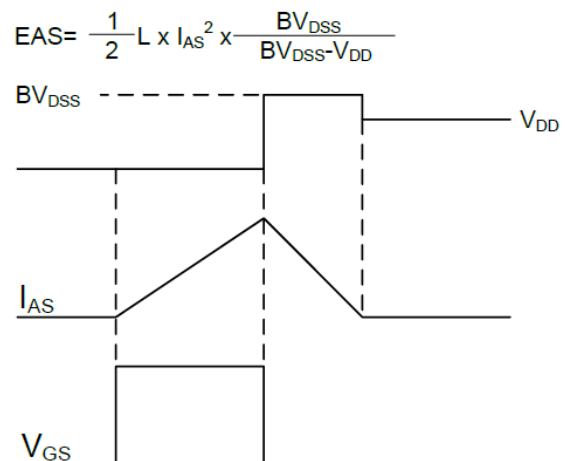


Fig.11 Unclamped Inductive Switching Wave